## IN THE SPECIFICATION

Please amend the Title at page 1, line 1 to read:

## METHOD OF FABRICATING A SEMICONDUCTOR DEVICE <u>INCLUDING A</u> <u>DIELECTRIC LAYER FORMED USING A REACTIVE AGENT</u>

Please amend the Abstract at page 18, lines 2-9 to read:

A method of fabricating a semiconductor device Semiconductor devices that utilize including a silicon-containing dielectric layer is provided are disclosed. In one embodiment, a silicon-containing material is deposited on a substrate. The deposited material is processed with a reactive agent to react with silicon atoms of the deposited material to form the dielectric layer. The silicon-containing dielectric layer provides for improved or smaller semiconductor devices by reducing leakage and increasing the dielectric constant.